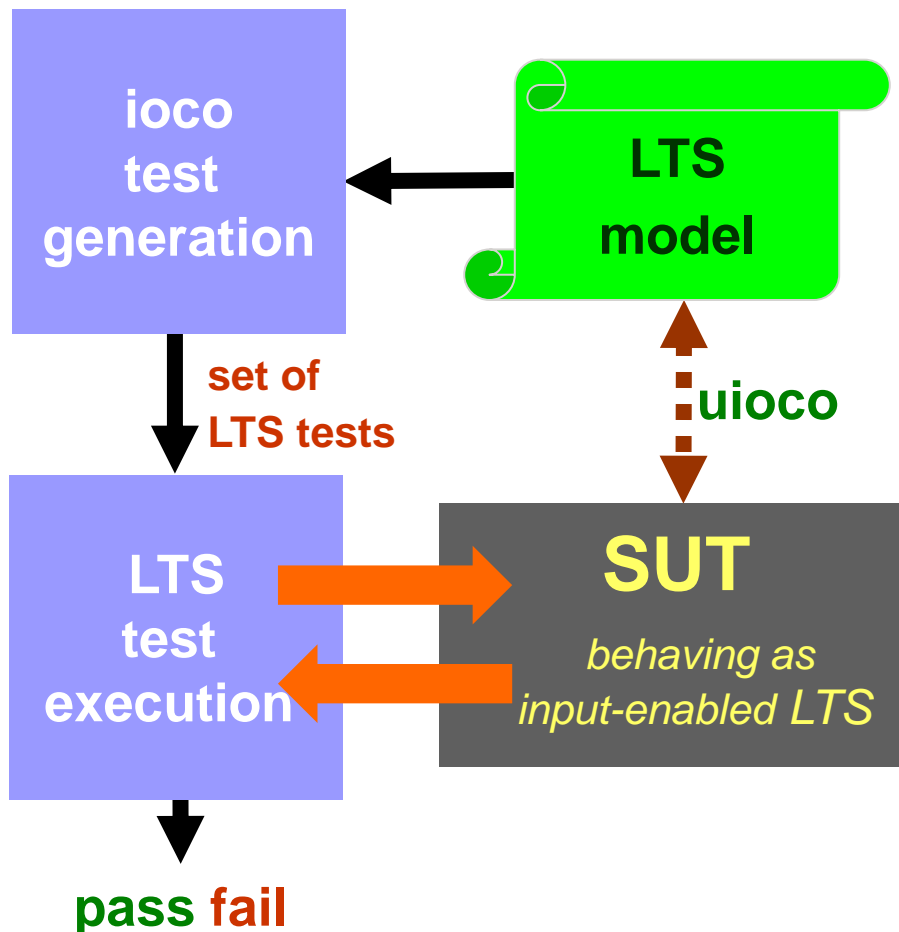


A Theory of Model-Based Testing with Labelled Transition Systems

*Test Generation for **uioco***

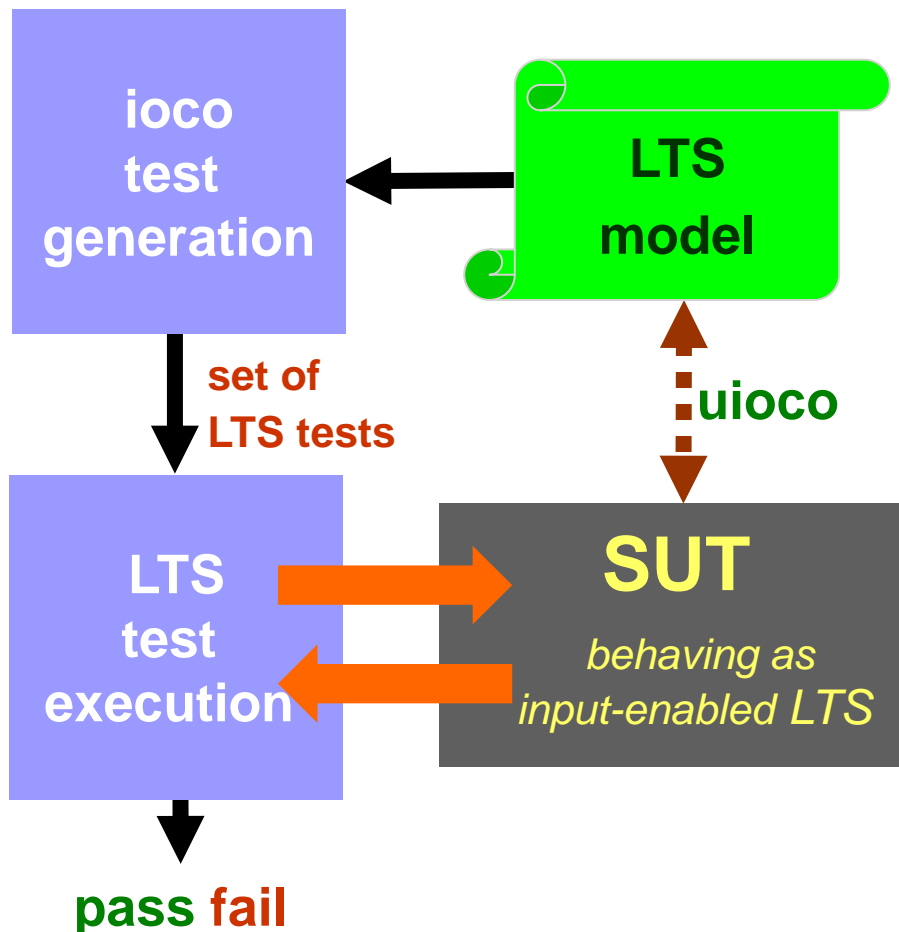
MBT : Labelled Transitions Systems



MBT with LTS topics:

- 👉 specification model
- 👉 implementation (SUT)
- 👉 implementation model
- 👉 conformance **uioco**
- 👉 test cases
- 👉 test generation
- 👉 test execution
- 👉 test result analysis
- 👉 sound & exhaustive

MBT : Labelled Transitions Systems



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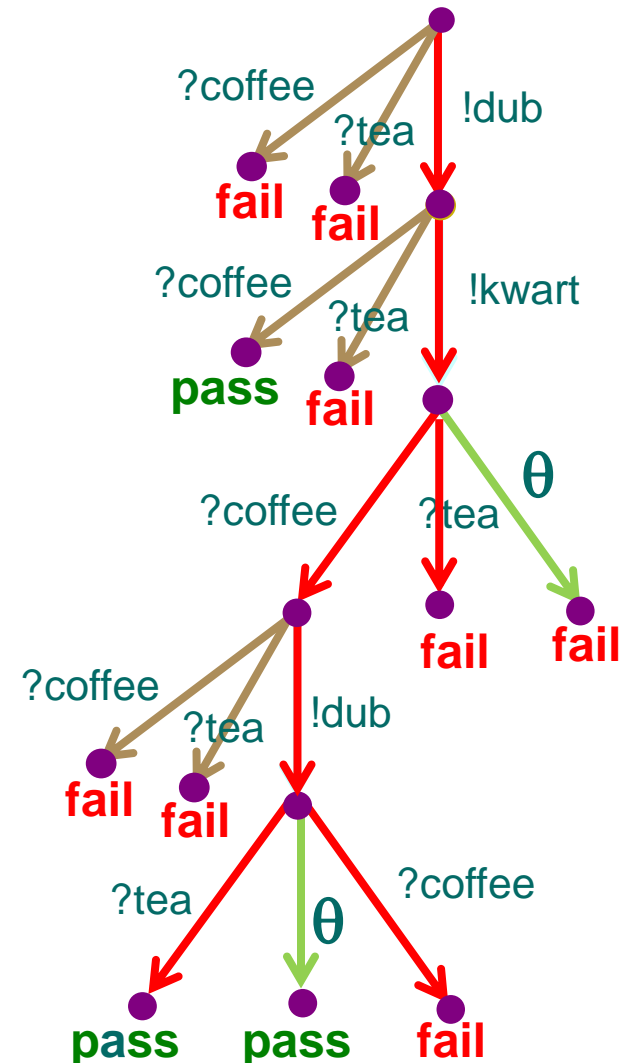
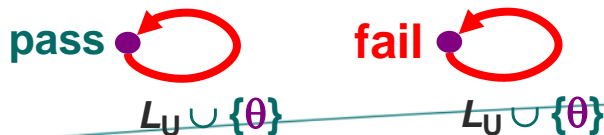
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Test Cases

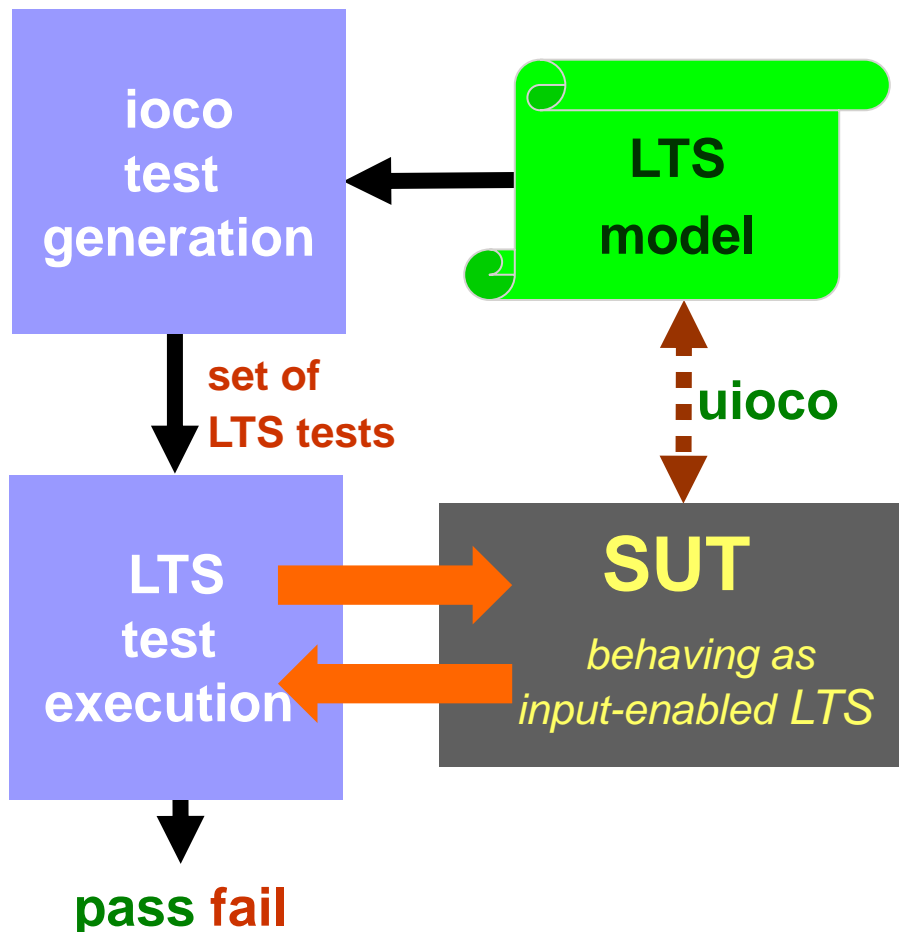
model of a test case

= labelled transition system

- labels in $L_I \cup L_U \cup \{\theta\}$
- ‘quiescence’ / ‘time-out’ label θ
- tree-structured
- finite, deterministic
- sink states **pass** and **fail**
- from each state \neq **pass**, **fail** :
 - either one input **!a** and all outputs **?x**
 - or all outputs **?x** and θ



MBT : Labelled Transitions Systems

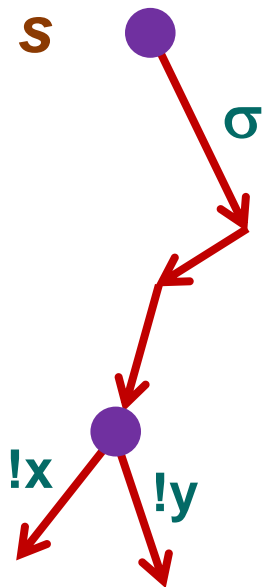


MBT with LTS topics:

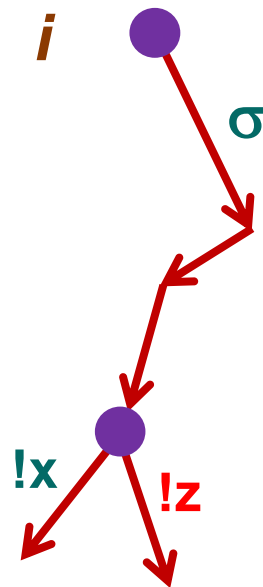
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Test Generation

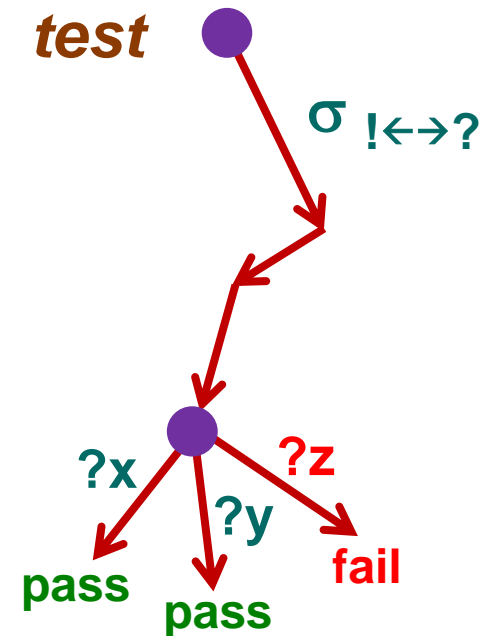
$i \text{ uioco } s \stackrel{\text{def}}{=} \forall \sigma \in \text{Utraces}(s) : \text{out}(i \text{ after } \sigma) \subseteq \text{out}(s \text{ after } \sigma)$



$\text{out}(s \text{ after } \sigma)$
 $= \{ !x, !y \}$



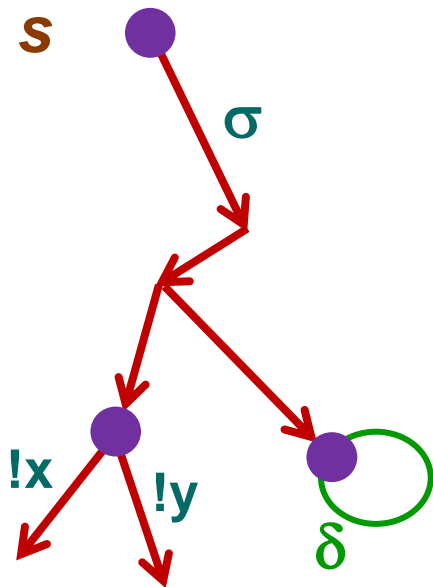
$\text{out}(i \text{ after } \sigma)$
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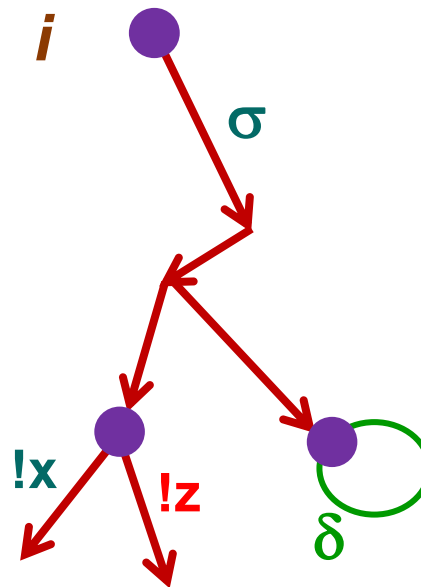
$\text{out}(test \text{ after } \sigma)$
 $= \{ !x, !y, !z \}$

Test Generation

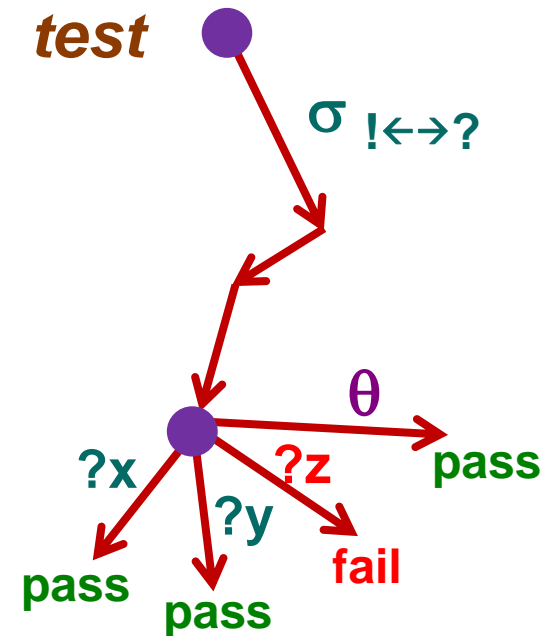
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$\text{out}(s \text{ after } \sigma)$
 $= \{ !x, !y, \delta \}$



$\text{out}(i \text{ after } \sigma)$
 $= \{ !x, !z, \delta \}$



$\text{out}(test \text{ after } \sigma)$
 $= \{ !x, !y, !z, \theta \}$

Test Generation Algorithm : *uioco*

Algorithm to generate a test case $t(S)$

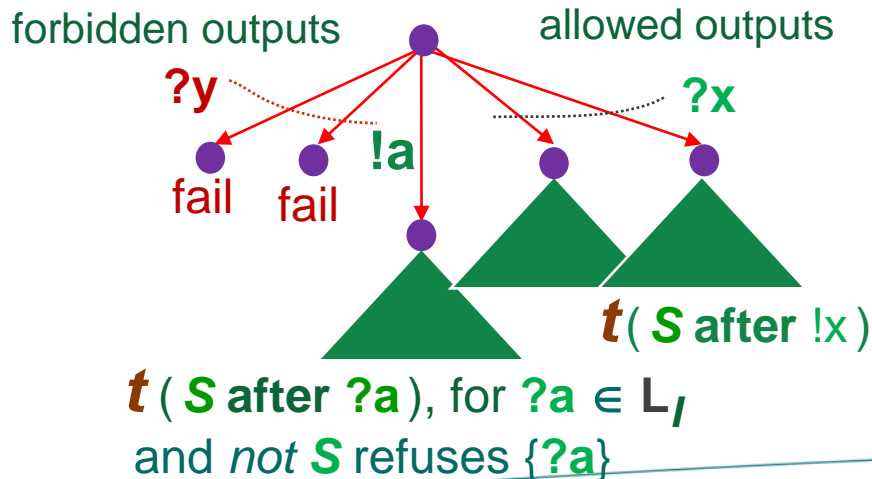
from a transition system state set S , with $S \neq \emptyset$, and initially $S = s_0$ after ε

Apply the following steps recursively, non-deterministically :

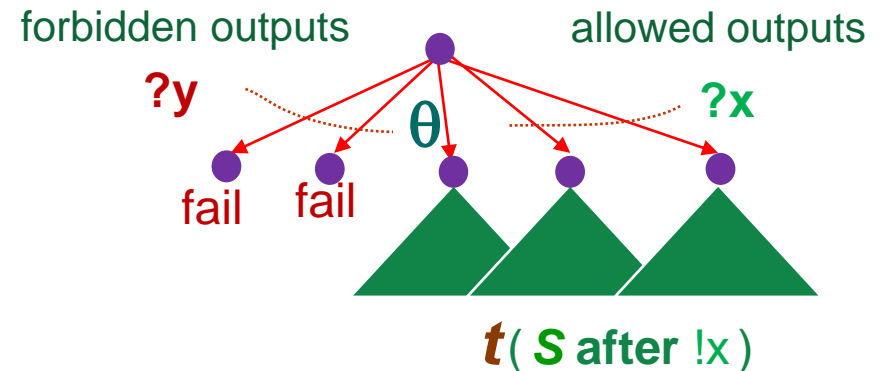
1 end test case

• pass

2 supply input $!a$



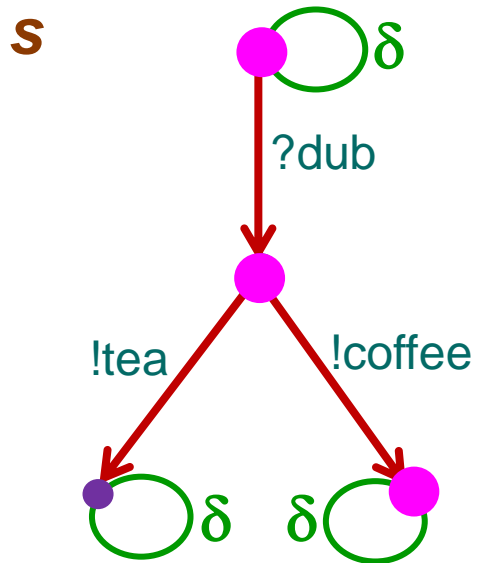
3 observe all outputs



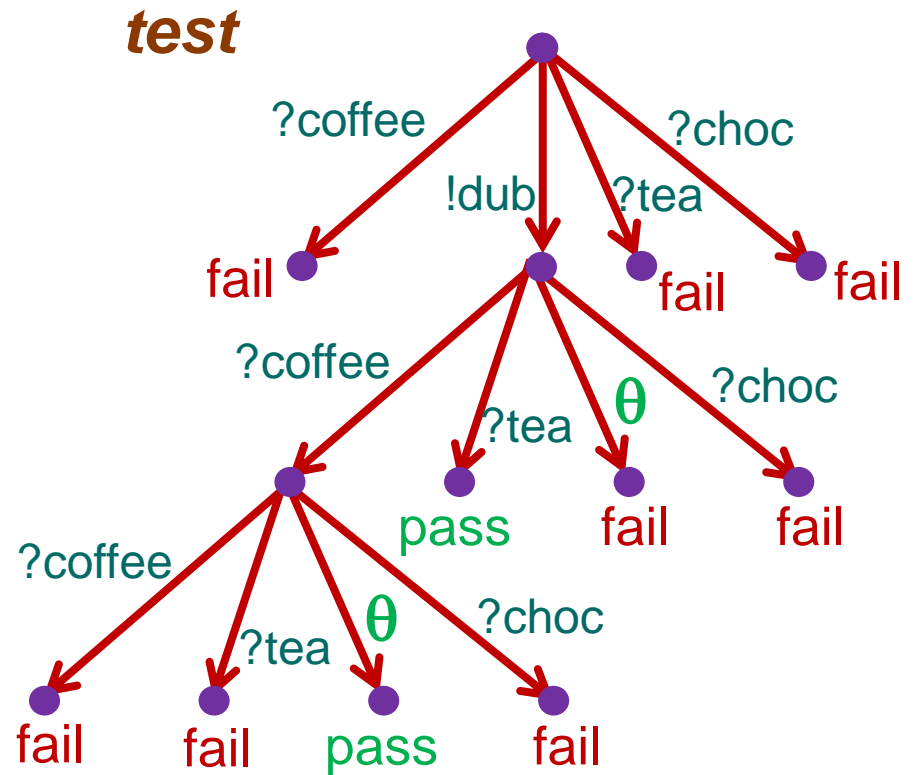
allowed outputs (or δ): $!x \in \text{out}(S)$

forbidden outputs (or δ): $!y \notin \text{out}(S)$

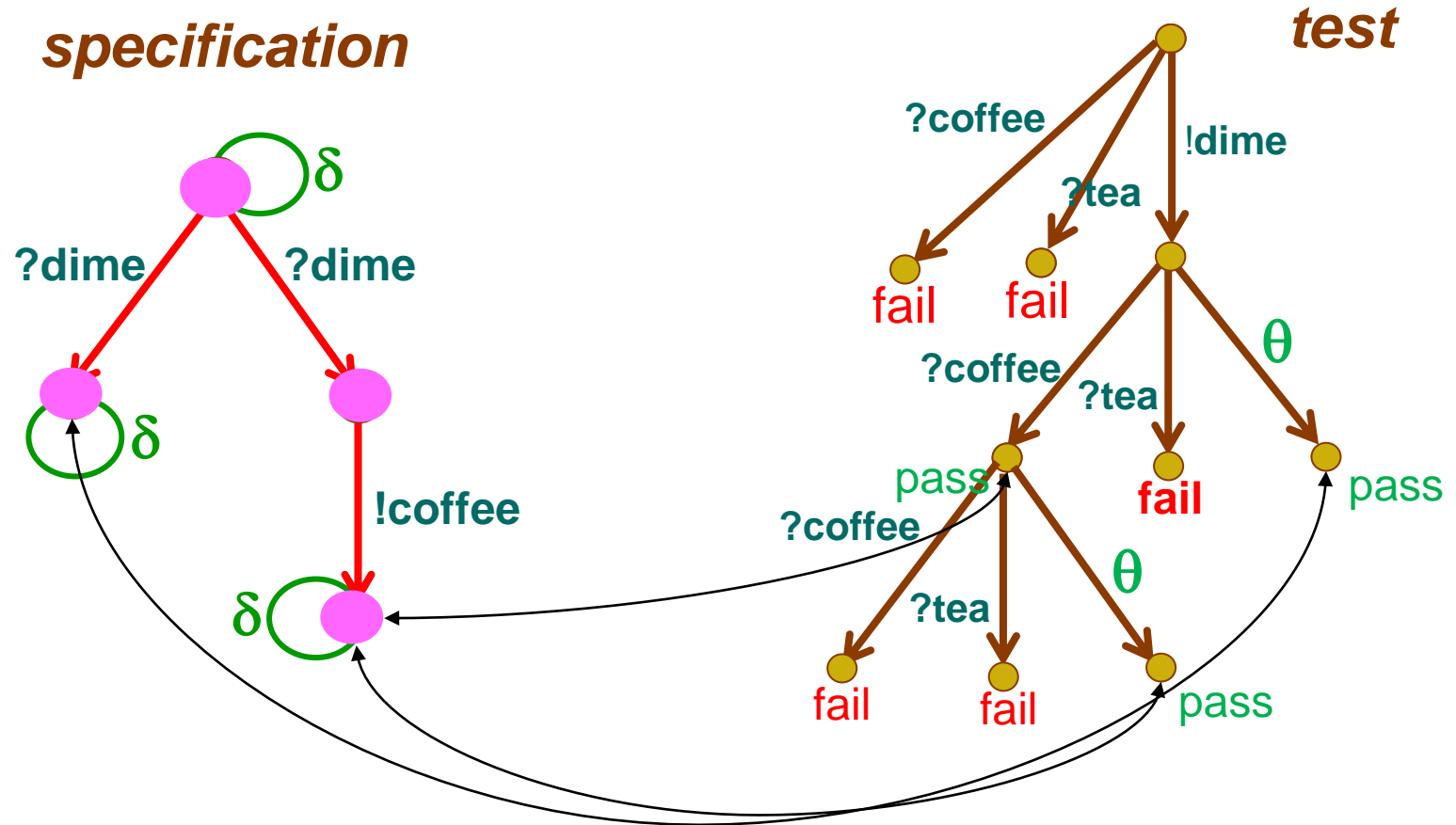
Example : *uioco* Test Generation



$L = \{ ?dub, !coffee, !tea, !choc \}$



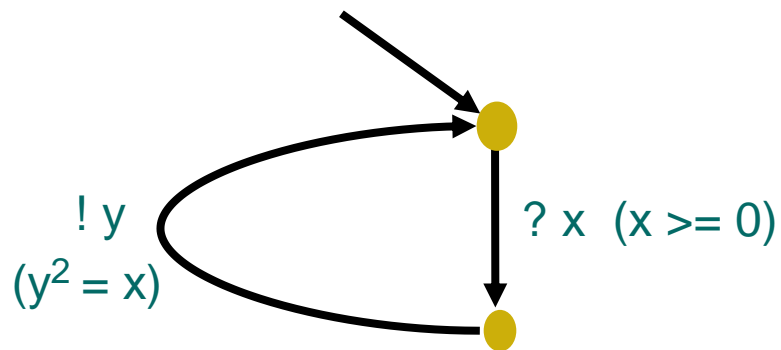
Example : *uioco* Test Generation



Example : *uioco* Test Generation

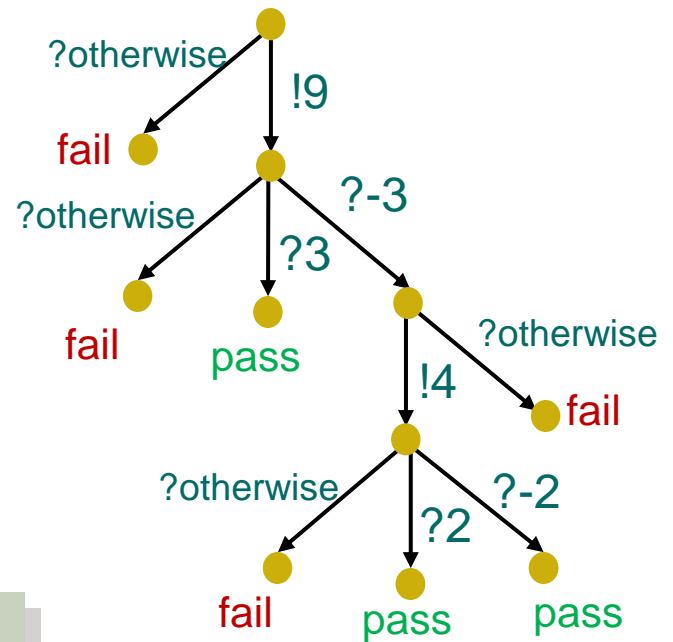
Equation solver for $y^2=x$

specification **s**

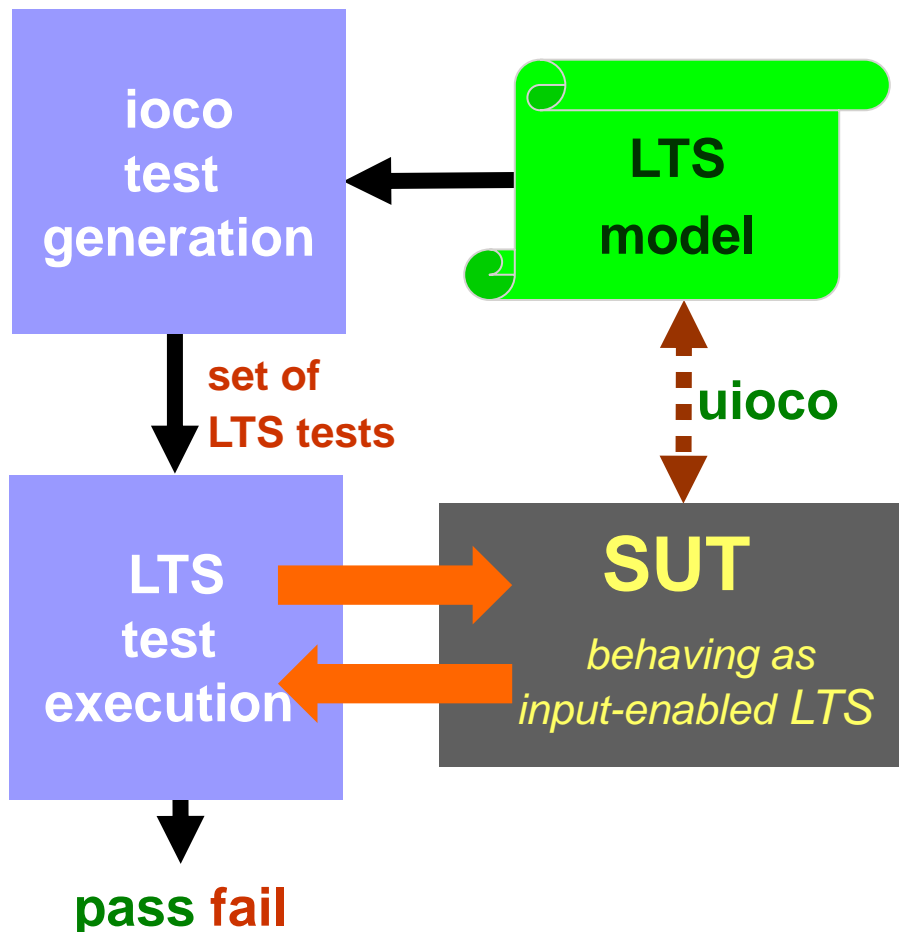


To cope with non-deterministic behaviour,
tests are not linear traces, but trees

test



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Test Execution

Test execution = all possible parallel test runs of test t
with implementation i going to state pass or fail

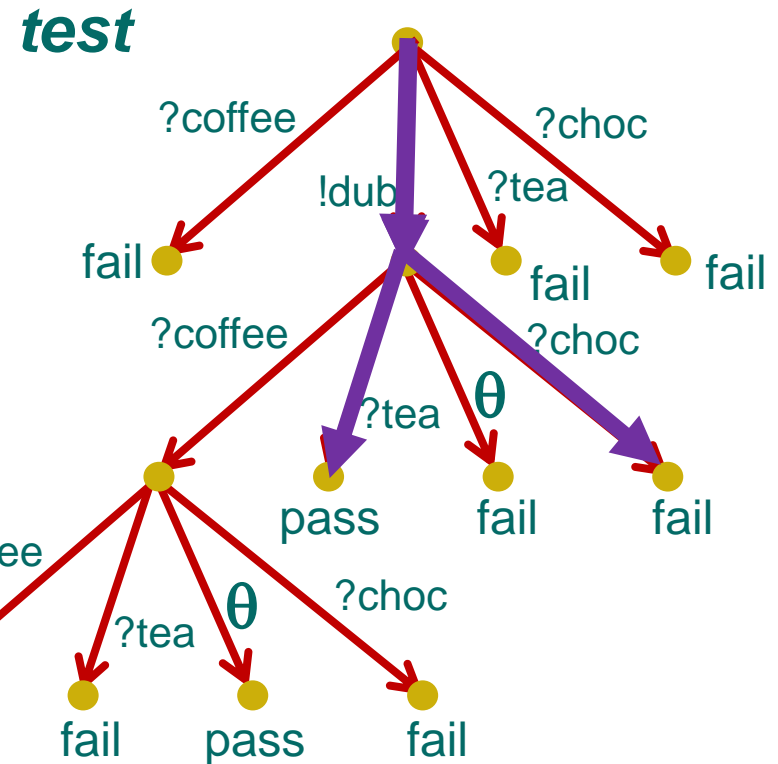
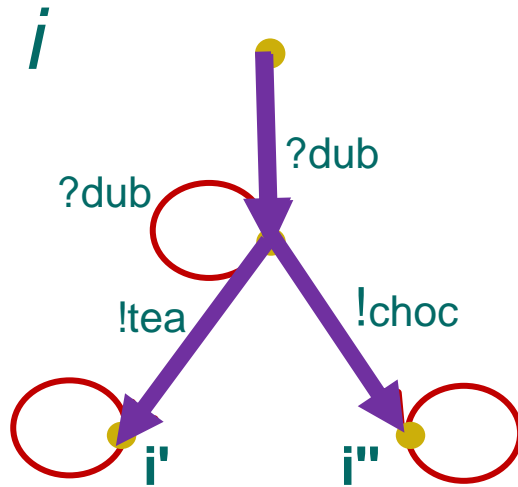
Test run : $t \parallel i \xrightarrow{\sigma} \text{pass} \parallel i'$ or $t \parallel i \xrightarrow{\sigma} \text{fail} \parallel i'$

$$\frac{t \xrightarrow{a} t', \quad i \xrightarrow{a} i'}{t \parallel i \xrightarrow{a} t' \parallel i'}$$

$$\frac{i \xrightarrow{\tau} i'}{t \parallel i \xrightarrow{\tau} t \parallel i'}$$

$$\frac{t \xrightarrow{\theta} t', \quad i \xrightarrow{\delta} i'}{t \parallel i \xrightarrow{\theta} t' \parallel i'}$$

Example : Test Execution



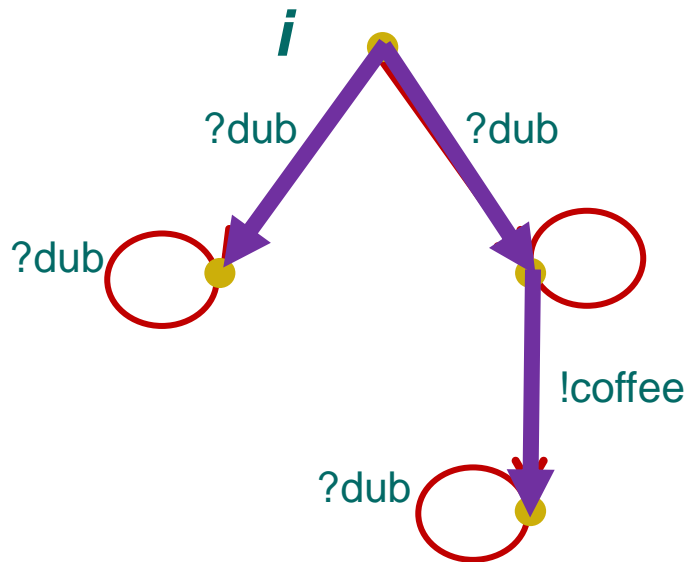
Two test runs :

$t \Vdash i \xRightarrow{\text{dub tea}} \text{pass} \Vdash i'$

$t \Vdash i \xRightarrow{\text{dub choc}} \text{fail} \Vdash i''$

i* fails *t

Example : Test Execution

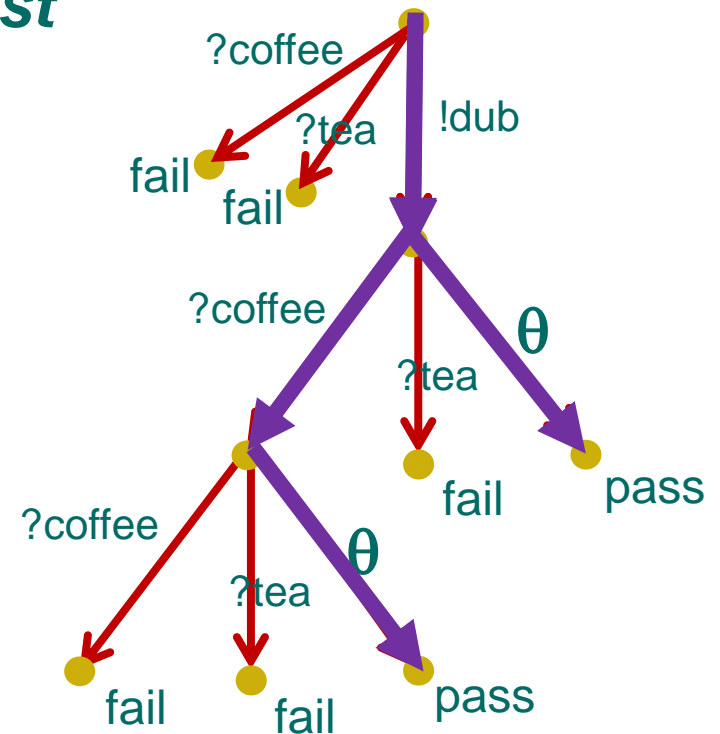


Two test runs :

$t \parallel i \xRightarrow{\text{dub } \theta} \text{pass} \parallel i'$

$t \parallel i \xRightarrow{\text{dub coffee } \theta} \text{pass} \parallel i'$

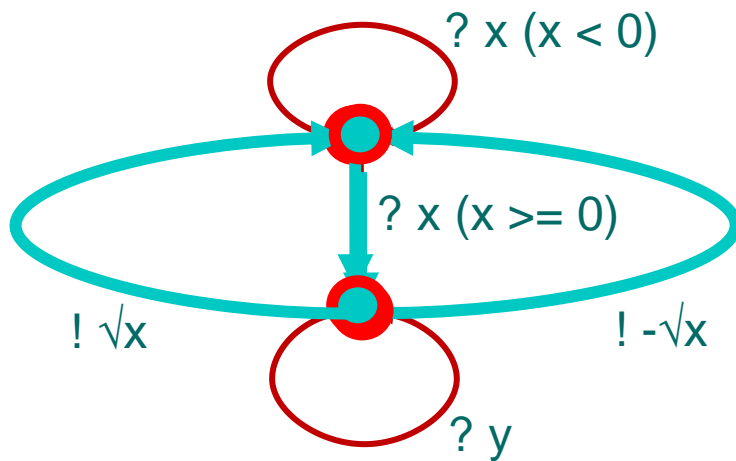
test



i passes *t*

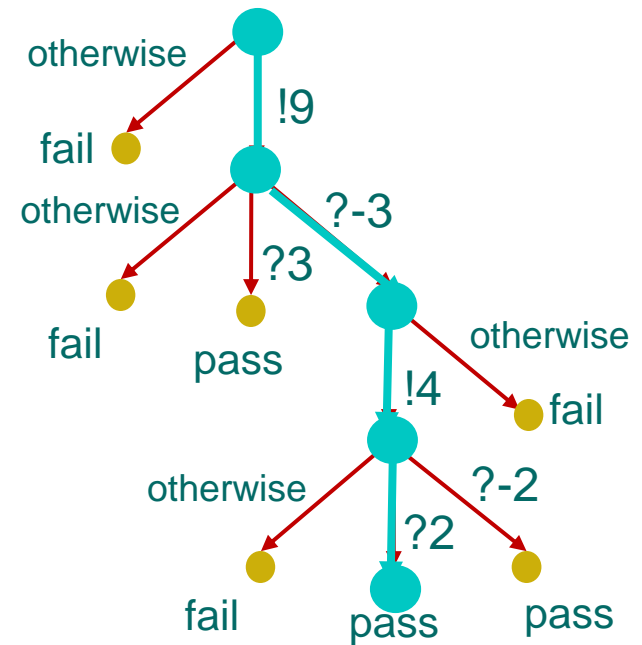
Example : Test Execution

implementation



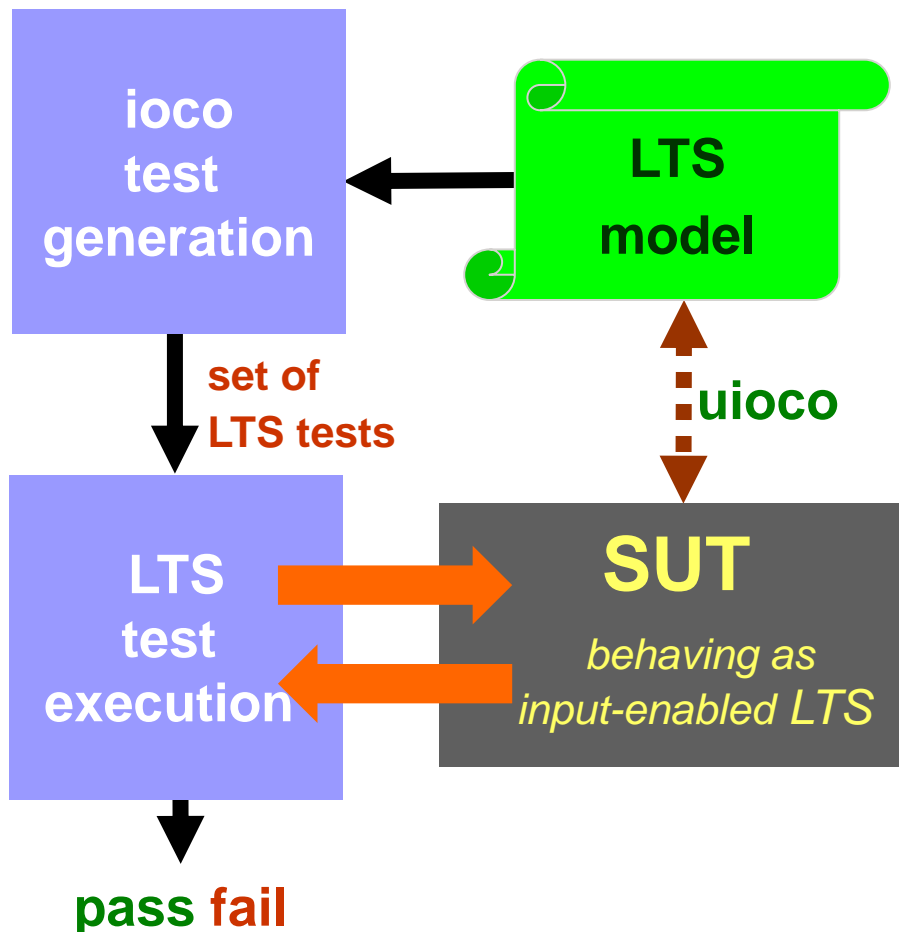
||

test



i passes t

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Validity of Test Generation

For every test t generated with algorithm we have:

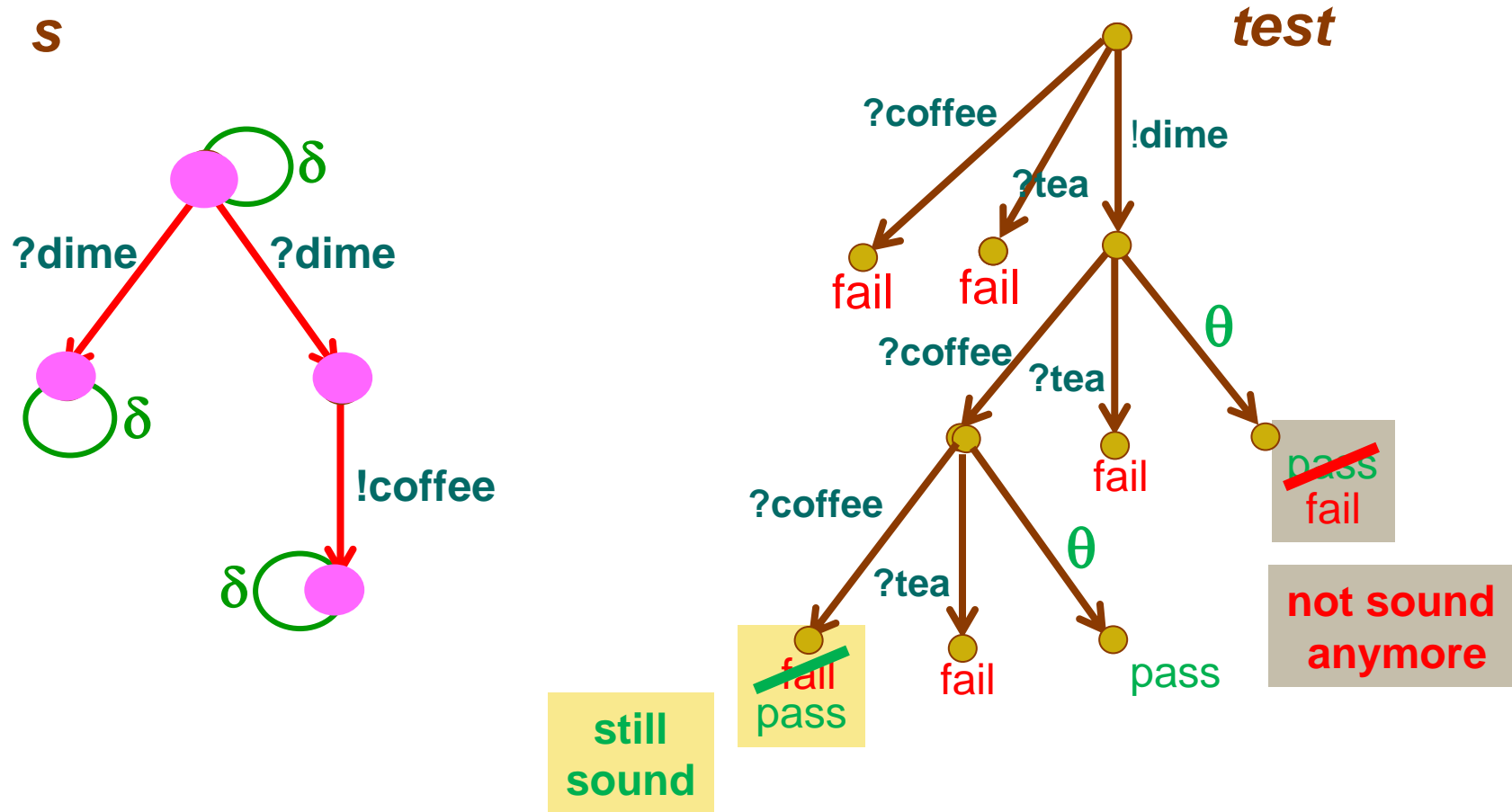
- **Soundness :**
 t will never fail with correct implementation

$i \text{ uioco } s$ implies $i \text{ passes } t$

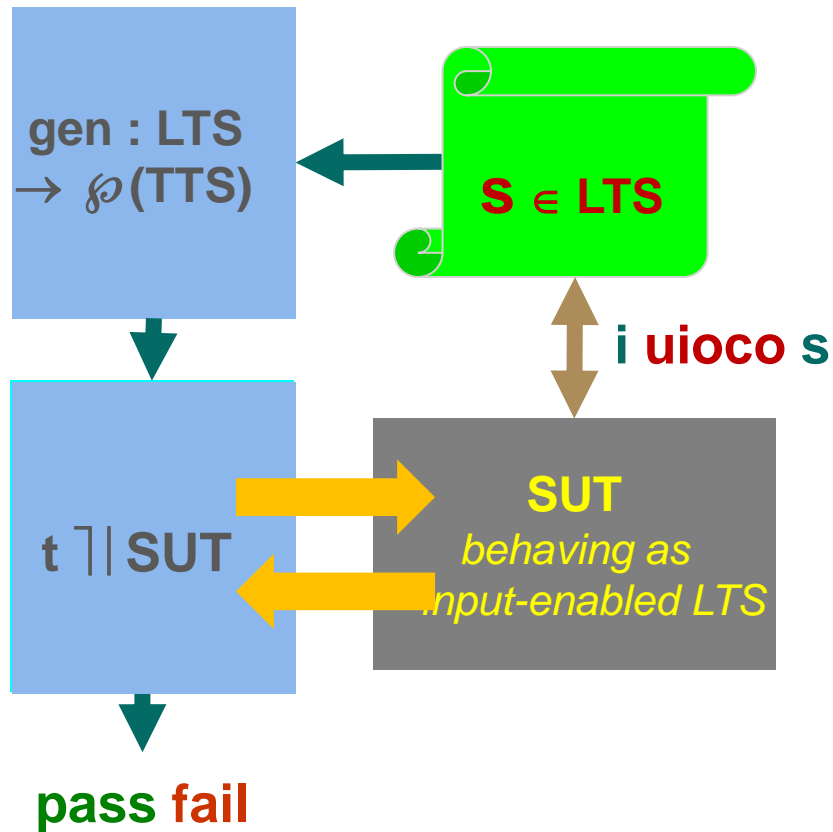
- **Exhaustiveness :**
each incorrect implementation can be detected
with a generated test t

~~$i \text{ uioco } s$~~ implies $\exists t : i \text{ fails } t$

Soundness and Exhaustiveness



MBT with *uioco* is Sound and Exhaustive



Testability assumption :

$\forall \text{SUT} \in \text{IMP} . \exists m_{\text{SUT}} \in \text{IOTS} .$

$\forall t \in \text{TESTS} .$

$\text{SUT passes } t \Leftrightarrow m_{\text{SUT}} \text{ passes } t$

Prove soundness and exhaustiveness:

$\forall m \in \text{IOTS} .$

$(\forall t \in \text{gen}(s) . m \text{ passes } t)$

$\Leftrightarrow m \text{ uioco } s$

SUT conforms to s

exhaustive $\Uparrow \Downarrow$ sound

SUT passes $\text{gen}(s)$

MBT : Model-Based Testing

